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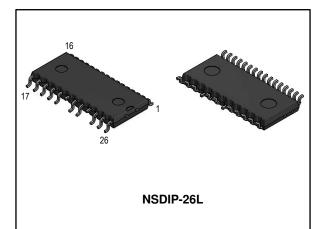


# STIPNS2M50-H



# SLLIMM<sup>™</sup>-nano small low-loss intelligent molded module IPM, 3-phase inverter, 2 A, 1.7 Ω max., 500 V MOSFET

Datasheet - production data



# Features

- IPM 2 A, 500 V, R<sub>DS(on)</sub> = 1.7 Ω, 3-phase MOSFET inverter bridge including control ICs for gate driving
- Optimized for low electromagnetic interference
- 3.3 V, 5 V, 15 V CMOS/TTL input comparators with hysteresis and pull-down/pull-up resistors
- Undervoltage lockout
- Internal bootstrap diode
- Interlocking function
- Comparator for fault protection against overtemperature and overcurrent
- Op-amp for advanced current sensing
- Optimized pinout for easy board layout
- Moisture sensitive level (MSL) 3

# Applications

- 3-phase inverters for small power motor drives
- Dish washers, refrigerator compressors, heating systems, air-conditioning fans, draining and recirculation pumps

# Description

This SLLIMM (small low-loss intelligent molded module) nano provides a compact, highperformance AC motor drive in a simple, rugged design. It is composed of six MOSFETs and three half-bridge HVICs for gate driving, providing low electromagnetic interference (EMI) characteristics with optimized switching speed. The package is optimized for thermal performance and compactness in built-in motor applications, or other low power applications where assembly space is limited. This IPM includes an operational amplifier, completely uncommitted, and a comparator that can be used to design a fast and efficient protection circuit. SLLIMM<sup>™</sup> is a trademark of STMicroelectronics.

#### Table 1: Device summary

Order code	Marking	Package	Packing
STIPNS2M50-H	IPNS2M50-H	NSDIP-26L	Tape and reel

DocID030528 Rev 2

This is information on a product in full production.

#### Contents

Con	tents		
1	Internal s	schematic diagram and pin configuration	.3
2	Electrica	I ratings	.6
	2.1	Absolute maximum ratings	6
	2.2	Thermal data	6
3	Electrica	I characteristics	.7
	3.1	Inverter part	7
	3.2	Control part	9
	3.3	Waveform definitions	12
4	Smart sh	utdown function	13
5	Applicati	on circuit example <sup>.</sup>	15
	5.1	Guidelines	16
6	Package	information	17
	6.1	NSDIP-26L package information	17
7	Revision	history	20



# 1 Internal schematic diagram and pin configuration

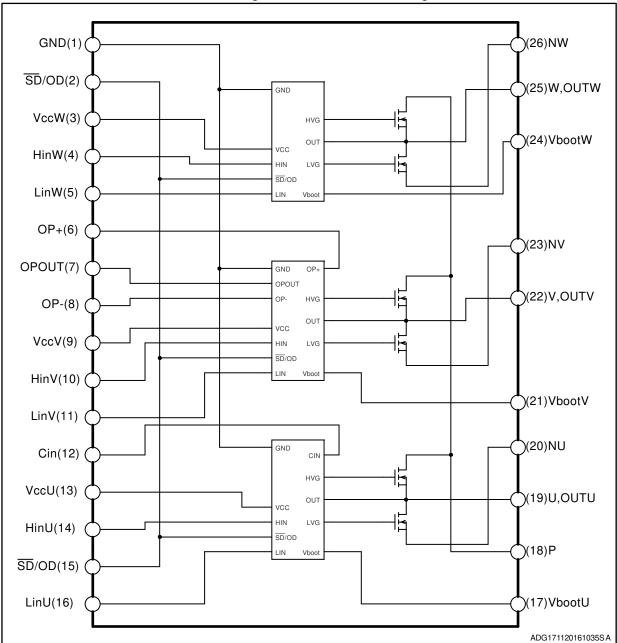


Figure 1: Internal schematic diagram



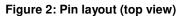
# Internal schematic diagram and pin configuration Table 2: Pin description

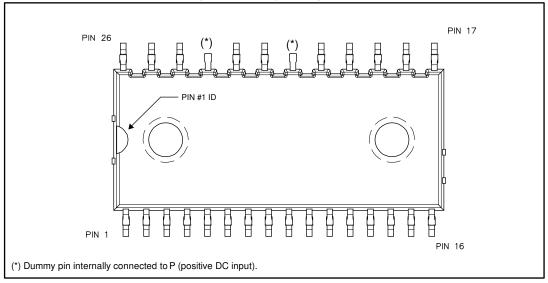
#### STIPNS2M50-H

Pin	Symbol	Description
1	GND	Ground
2	<u>SD</u> /OD	Shutdown logic input (active low) / open-drain (comparator output)
3	Vcc W	Low voltage power supply W phase
4	HIN W	High-side logic input for W phase
5	LIN W	Low-side logic input for W phase
6	OP+	Op-amp non inverting input
7	OPout	Op-amp output
8	OP-	Op-amp inverting input
9	Vcc V	Low voltage power supply V phase
10	HIN V	High-side logic input for V phase
11	LIN V	Low-side logic input for V phase
12	CIN	Comparator input
13	Vcc U	Low voltage power supply for U phase
14	HIN U	High-side logic input for U phase
15	$\overline{\text{SD}}/\text{OD}$	Shutdown logic input (active low) / open-drain (comparator output)
16	LIN U	Low-side logic input for U phase
17	VBOOT U	Bootstrap voltage for U phase
18	Р	Positive DC input
19	U, OUTu	U phase output
20	Nυ	Negative DC input for U phase
21	VBOOT V	Bootstrap voltage for V phase
22	$V, OUT_V$	V phase output
23	Nv	Negative DC input for V phase
24	VBOOT W	Bootstrap voltage for W phase
25	W, OUT <sub>W</sub>	W phase output
26	Nw	Negative DC input for W phase



Internal schematic diagram and pin configuration







# 2 Electrical ratings

# 2.1 Absolute maximum ratings

Symbol	Symbol Parameter Value					
VDSS	MOSFET blocking voltage (or drain-source voltage) for each MOSFET ( $V_{IN}^{(1)}=0$ )	500	V			
±ΙD	Continuous current each MOSFET	2	А			
±1 <sub>DP</sub> <sup>(2)</sup>	Peak drain current each MOSFET (less than 1 ms)	4	А			
P <sub>TOT</sub>	Each MOSFET total dissipation at $T_C$ = 25 °C	10.4	W			

#### Notes:

 $^{(1)}\mbox{Applied}$  among HINi, LINi and GND for i = U, V, W.

 $^{(2)}\mbox{Pulse}$  width limited by max. junction temperature.

Symbol	SymbolParameterMin.Max.						
Vout	Output voltage applied among OUT <sub>U</sub> , OUT <sub>V</sub> , OUT <sub>W</sub> - GND	V <sub>boot</sub> - 21	V <sub>boot</sub> + 0.3	V			
V <sub>CC</sub>	Low voltage power supply	- 0.3	21	V			
VCIN	Comparator input voltage	- 0.3	Vcc + 0.3	V			
V <sub>op+</sub>	Op-amp non-inverting input	- 0.3	Vcc + 0.3	V			
V <sub>op-</sub>	Op-amp inverting input	- 0.3	$V_{CC} + 0.3$	V			
V <sub>boot</sub>	Bootstrap voltage	- 0.3	620	V			
VIN	Logic input voltage applied among HIN, LIN and GND	- 0.3	15	V			
$V_{\overline{SD}/OD}$	Open-drain voltage	- 0.3	15	V			
$\Delta V_{\text{OUT/dT}}$	Allowed output slew rate		50	V/ns			

#### Table 4: Control part

#### Table 5: Total system

Symbol	Parameter	Value	Unit
Viso	Isolation withstand voltage applied on each pin and heatsink plate (AC voltage, $t = 60 s$ )	1000	V
Tj	Power chip operating junction temperature	-40 to 150	°C
Tc	Module case operation temperature	-40 to 125	°C

# 2.2 Thermal data

#### Table 6: Thermal data

Symbol	Parameter	Value	Unit
Rth(j-c)	Thermal resistance junction-case	12	°C/W

DocID030528 Rev 2	
	-



# 3 Electrical characteristics

 $T_{\rm J}$  = 25 °C unless otherwise specified.

## 3.1 Inverter part

	Table 7: Static						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
IDSS	Zero-gate voltage drain current	$\label{eq:VDS} \begin{array}{l} V_{\text{DS}} = 500 \ \text{V}, \ V_{\text{CC}} = 15 \ \text{V}, \\ V_{\text{Boot}} = 15 \ \text{V} \end{array}$			1	mA	
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$\label{eq:Vcc} \begin{array}{l} V_{\text{CC}} = V_{\text{boot}} = 15 \ \text{V}, \ V_{\text{IN}}{}^{(1)} = 0 \ \text{V}, \\ I_{\text{D}} = 1 \ \text{mA} \end{array}$	500			V	
R <sub>DS(on)</sub>	Static drain source turn-on resistance			1.5	1.7	Ω	
V <sub>SD</sub>	Drain-source diode forward voltage	$V_{IN}^{(1)}$ = 0 "logic state", $I_D$ = 2 A		0.9	1.6	V	

#### Notes:

 $^{(1)}\mbox{Applied}$  among HINx, LINx and GND for x = U, V, W.

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
Symbol	Falainetei	Test conditions	IVIIII.	тур.	IVIAX.	Unit
ton <sup>(1)</sup>	Turn-on time		-	267	-	
t <sub>c(on)</sub> <sup>(1)</sup>	Crossover time (on)		I	153	-	
toff <sup>(1)</sup>	Turn-off time	$V_{DD} = 300 \text{ V},$ $V_{CC} = V_{boot} = 15 \text{ V},$ $V_{IN}^{(2)} = 0 - 5 \text{ V},$ $I_{C} = 1.2 \text{ A}$ (see Figure 4: "Switching time definition")	-	265	-	ns
t <sub>c(off)</sub> <sup>(1)</sup>	Crossover time (off)		-	46	-	
trr	Reverse recovery time		I	192	-	
Eon	Turn-on switching energy		-	61	-	
E <sub>off</sub>	Turn-off switching energy		-	4	-	μJ

#### Table 8: Inductive load switching time and energy

#### Notes:

 $^{(1)}\text{ton}$  and toFF include the propagation delay time of the internal drive.  $t_{C(ON)}$  and  $t_{C(OFF)}$  are the switching time of MOSFET itself under the internally given gate driving conditions.

<sup>(2)</sup>Applied among HINx, LINx and GND for x = U, V, W.



#### **Electrical characteristics**

#### STIPNS2M50-H

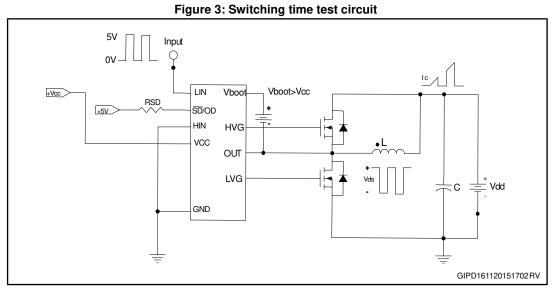
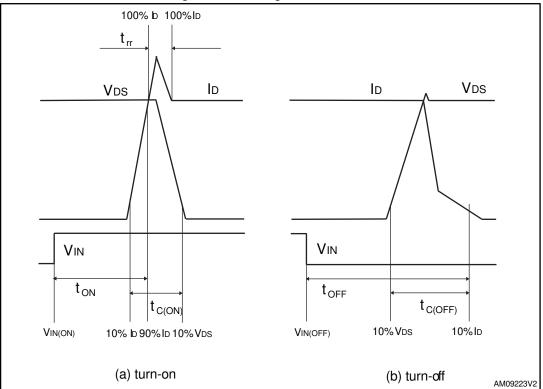


Figure 4: Switching time definition







# 3.2 Control part

 $(V_{CC} = 15 \text{ V unless otherwise specified}).$ 

Table 9: Low	voltage	power	supply
--------------	---------	-------	--------

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{CC\_hys}$	V <sub>CC</sub> UV hysteresis		1.2	1.5	1.8	V
Vcc_thON	Vcc UV turn-ON threshold		11.5	12	12.5	V
$V_{\text{CC\_thOFF}}$	V <sub>CC</sub> UV turn-OFF threshold		10	10.5	11	V
I <sub>qccu</sub>	Undervoltage quiescent supply current	$\label{eq:VCC} \begin{split} V_{CC} &= 10 \ V, \ \overline{\text{SD}}/\text{OD} = 5 \ V; \\ \text{LIN} &= 0 \ V; \ \text{H}_{\text{IN}} = 0, \ \text{C}_{\text{IN}} = 0 \end{split}$			150	μA
Iqcc	Quiescent current	$\label{eq:Vcc} \begin{split} V_{cc} &= 15 \text{ V},  \overline{\text{SD}}/\text{OD} = 5 \text{ V}; \\ \text{LIN} &= 0 \text{ V};  \text{H}_{\text{IN}} = 0,  \text{C}_{\text{IN}} = 0 \end{split}$			1	mA
V <sub>ref</sub>	Internal comparator (CIN) reference voltage		0.5	0.54	0.58	V

Table 10: Bootstrapped voltage	е
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Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{BS\_hys}$	V <sub>BS</sub> UV hysteresis		1.2	1.5	1.8	V
$V_{BS\_thON}$	V <sub>BS</sub> UV turn-ON threshold		11.1	11.5	12.1	V
$V_{\text{BS\_thOFF}}$	V <sub>BS</sub> UV turn-OFF threshold		9.8	10	10.6	V
I <sub>QBSU</sub>	Undervoltage V <sub>BS</sub> quiescent current	$\label{eq:BS_states} \begin{array}{l} V_{BS} < 9 \ V, \ \overline{\text{SD}} / \text{OD} = 5 \ V; \\ \text{LIN} = 0 \ V \ \text{and} \ \text{HIN} = 5 \ V; \\ \text{C}_{\text{IN}} = 0 \end{array}$		70	110	μA
I <sub>QBS</sub>	V <sub>BS</sub> quiescent current	$\label{eq:VBS} \begin{array}{l} V_{BS} = 15 \ V, \ \overline{\text{SD}}/\text{OD} = 5 \ V; \\ \text{LIN} = 0 \ V \ \text{and} \ \text{HIN} = 5 \ V; \\ \text{C}_{\text{IN}} = 0 \end{array}$		200	300	μA
R <sub>DS(on)</sub>	Bootstrap driver on-resistance	LVG ON		120		Ω



#### **Electrical characteristics**

#### STIPNS2M50-H

	Table 11: Logic inputs							
Symbol	Parameter Test conditions		Min.	Тур.	Max.	Unit		
Vil	Low logic level voltage				0.8	V		
Vih	High logic level voltage		2.25			V		
IHINN	HIN logic "1" input bias current	HIN = 15 V	20	40	100	μA		
I <sub>HINI</sub>	HIN logic "0" input bias current HIN = 0 V				1	μΑ		
ILINI	LIN logic "1" input bias current	LIN = 15 V	20	40	100	μA		
I <sub>LINh</sub>	LIN logic "0" input bias current	LIN = 0 V			1	μA		
ISDh	SD logic "0" input bias current	<u>SD</u> = 15 V	30	120	300	μA		
I <sub>SDI</sub>	SD logic "1" input bias current	$\overline{\text{SD}} = 0 \text{ V}$			3	μΑ		
Dt	Dead time	(see Figure 5: "Dead time and interlocking waveform definitions")		180		ns		

#### Table 12: Op-amp characteristics

Symbol	Parameter Test conditions		Min.	Тур.	Max.	Unit
Vio	Input offset voltage	$V_{ic} = 0 \ V, \ V_o = 7.5 \ V$			6	mV
lio	Input offset current	$V_{ic} = 0 V. V_0 = 7.5 V$		4	40	nA
l <sub>ib</sub>	Input bias current (1)	$v_{ic} = 0 v, v_0 = 7.5 v$		100	200	nA
Vol	Low level output voltage	$R_L$ = 10 k $\Omega$ to V <sub>CC</sub>		75	150	mV
Vон	High level output voltage	$R_L$ = 10 k $\Omega$ to GND	14	14.7		V
	Output short-circuit	Source, $V_{id} = +1 V$ ; $V_o = 0 V$	16	30		mA
lo	current	Sink, $V_{id} = -1 V$ ; $V_o = V_{CC}$	50	80		mA
SR	Slew rate	$V_i = 1 - 4 V$ ; $C_L = 100 pF$ ; unity gain	2.5	3.8		V/µs
GBWP	Gain bandwidth product	V <sub>o</sub> = 7.5 V	8	12		MHz
A <sub>vd</sub>	Large signal voltage gain	$R_L = 2 k\Omega$	70	85		dB
SVR	Supply voltage rejection ratio	vs. V <sub>CC</sub>	60	75		dB
CMRR	Common mode rejection ratio		55	70		dB

#### Notes:

 $^{(1)}\mbox{The}$  direction of the input current is out of the IC.





#### Electrical characteristics

	Table 13: Sense comparator characteristics						
Symbol	Parameter Test conditions		Min.	Тур.	Max.	Unit	
l <sub>ib</sub>	Input bias current	V <sub>CIN</sub> = 1 V			1	μA	
$V_{\text{od}}$	Open-drain low level output voltage	$I_{\text{od}} = 3 \text{ mA}$			0.5	>	
RON_OD	DD Open-drain low level output resistance Iod = 3 mA			166		Ω	
RPD_SD	SD pull-down resistor <sup>(1)</sup>			125		kΩ	
td_comp	<sup>mp</sup> Comparator delay <sup>SD</sup> /OD pulled to 5 V through 100 kΩ resistor			90	130	ns	
SR	Slew rate	$C_L$ = 180 pF; $R_{pu}$ = 5 k $\Omega$		60		V/µs	
t <sub>sd</sub>	Shutdown to high / low-side driver propagation delay		50	125	200		
tisd	Comparator triggering to high / low-side driver turn-off propagation delay	Measured applying a voltage step from 0 V to 3.3 V to pin CIN	50	200	250	ns )	

#### Notes:

 $^{(1)}\mbox{Equivalent}$  values as a result of the resistances of three drivers in parallel.

#### Table 14: Truth table

Conditions	Logic input (Vı)			Output		
Conditions	<b>SD</b> /OD	LIN	HIN	LVG	HVG	
Shutdown enable half-bridge tri-state	L	X <sup>(1)</sup>	X <sup>(1)</sup>	L	L	
Interlocking half-bridge tri-state	Н	Н	Н	L	L	
0 "logic state" half-bridge tri-state	Н	L	L	L	L	
1 "logic state" low-side direct driving	Н	Н	L	Н	L	
1 "logic state" high-side direct driving	Н	L	Н	L	Н	

#### Notes:

<sup>(1)</sup>X: do not care.



## 3.3 Waveform definitions

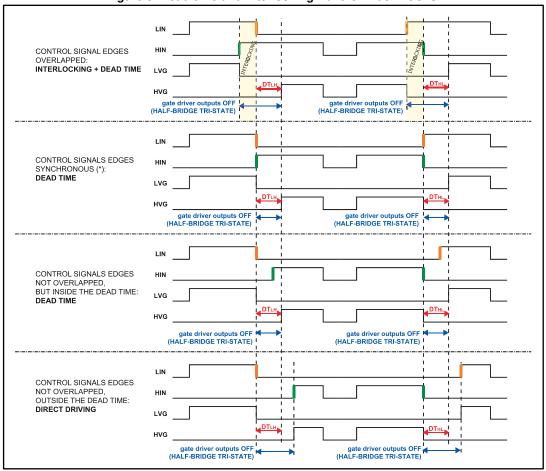


Figure 5: Dead time and interlocking waveform definitions



# 4 Smart shutdown function

The device integrates a comparator for fault sensing purposes. The comparator has an internal voltage reference  $V_{\text{REF}}$  connected to the inverting input, while the non-inverting input on pin (CIN) can be connected to an external shunt resistor for simple overcurrent protection.

When the comparator triggers, the device is set to the shutdown state and both of its outputs are set to the low level, causing the half-bridge to enter a tri-state.

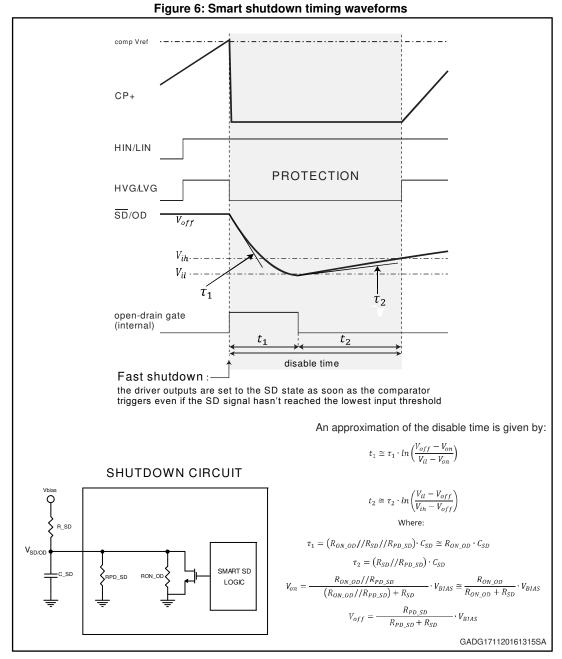
In common overcurrent protection architectures, the comparator output is usually connected to the shutdown input through an RC network so to provide a monostable circuit which implements a protection time following to a fault condition.

Our smart shutdown architecture immediately turns off the output gate driver in case of overcurrent through a preferential path for the fault signal which directly switches off the outputs. The time delay between the fault and output shutdown no longer depends on the RC values of the external network connected to the shutdown pin. At the same time, the DMOS connected to the open-drain output (pin  $\overline{SD}/OD$ ) is turned on by the internal logic, which holds it on until the shutdown voltage is well below the minimum value of logic input threshold (Vil).

Besides, the smart shutdown function allows the real disable time to be increased while the constant time of the external RC network remains as it is.



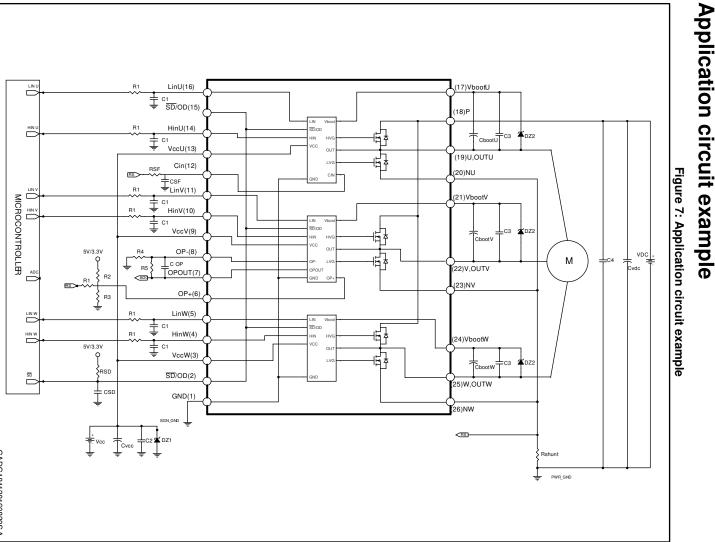
#### Smart shutdown function



Please refer to *Table 13: "Sense comparator characteristics"* for internal propagation delay time details.



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# Application designers are free to use a different scheme according to the specifications of the device. GADG181120160820S A

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DocID030528 Rev 2

#### 5.1 Guidelines

- Input signals HIN, LIN are active high logic. A 375 kΩ (typ.) pull-down resistor is builtin for each input. To prevent the input signal oscillation, the wiring of each input should be as short as possible and the use of RC filters (R1, C1) on each input signal is suggested. The filters should be with a time constant of about 100 ns and placed as close as possible to the IPM input pins.
- The use of a bypass capacitor CVCC (aluminum or tantalum) can help to reduce the transient circuit demand on the power supply. Besides, to reduce high frequency switching noise distributed on the power lines, a decoupling capacitor C<sub>2</sub> (100 to 220 nF, with low ESR and low ESL) should be placed as close as possible to V<sub>cc</sub> pin and in parallel with the bypass capacitor.
- The use of RC filter (RSF, CSF) is recommended to avoid protection circuit malfunction. The time constant (RSF x CSF) should be set to 1 µs and the filter must be placed as close as possible to CIN pin.
- The SD is an input/output pin (open-drain type if it is used as output). The CSD capacitor of the filter on SD should be fixed no higher than 3.3 nF in order to ensure the SD activation time T<sub>1</sub> <= 500 ns; the filter should be placed as close as possible to the SD pin.</li>
- The decoupling capacitor C<sub>3</sub> (from 100 to 220 nF, ceramic with low ESR and low ESL), in parallel with each C<sub>boot</sub>, is useful to filter high frequency disturbance. Both C<sub>boot</sub> and C<sub>3</sub> (if present) should be placed as close as possible to the U, V, W and V<sub>boot</sub> pins. Bootstrap negative electrodes should be connected to U, V, W terminals directly and separated from the main output wires.
- To prevent the overvoltage on V<sub>cc</sub> pin, a Zener diode (Dz1) can be used. Similarly on the V<sub>boot</sub> pin, a Zener diode (Dz2) can be placed in parallel with each C<sub>boot</sub>.
- The use of the decoupling capacitor C<sub>4</sub> (100 to 220 nF, with low ESR and low ESL) in parallel with the electrolytic capacitor C<sub>vdc</sub> is useful to prevent surge destruction. Both capacitors C<sub>4</sub> and C<sub>vdc</sub> should be placed as close as possible to the IPM (C<sub>4</sub> has priority over C<sub>vdc</sub>).
- By integrating an application-specific type HVIC inside the module, coupling to the MCU terminals without an optocoupler is possible.
- Low inductance shunt resistors should be used for phase leg current sensing.
- In order to avoid malfunctions, the wiring on N pins, the shunt resistor and PWR\_GND should be as short as possible.
- The connection of SGN\_GND to PWR\_GND on one point only (close to the shunt resistor terminal) can help to reduce the impact of power ground fluctuation.

These guidelines ensure the specifications of the device for application designs. For further details, please refer to the relative application note.

Symbol	Parameter Test conditions		Min.	Тур.	Max.	Unit
V <sub>PN</sub>	Supply voltage	Applied among P-Nu, Nv, Nw		300	400	V
Vcc	Control supply voltage	Applied to Vcc-GND	13.5	15	18	V
V <sub>BS</sub>	High-side bias voltage	Applied to $V_{BOOTi}$ -OUT <sub>i</sub> for i = U, V, W	13		18	V
t <sub>dead</sub>	Blanking time to prevent arm-short	For each input signal	1			μs
fрwм	PWM input signal	-40 °C < T₀ < 100 °C -40 °C < Tј < 125 °C			25	kHz
Tc	Case operation temperature				100	°C

Table 15: Recommended operating conditions

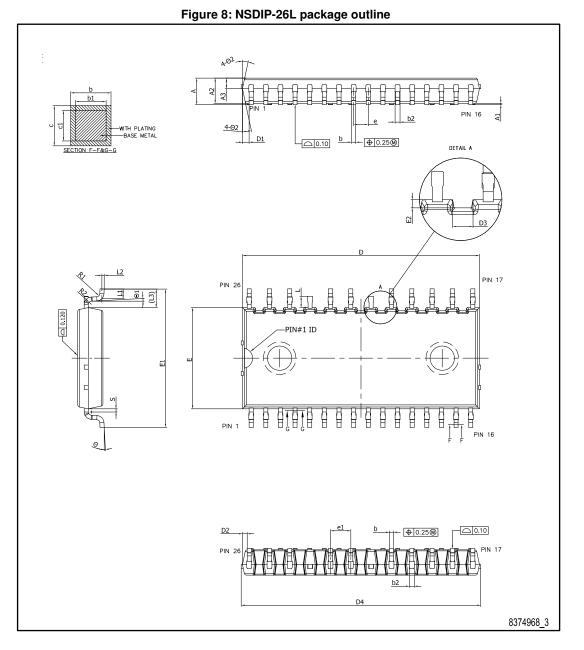


57

# 6 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.

# 6.1 NSDIP-26L package information



DocID030528 Rev 2

#### Package information

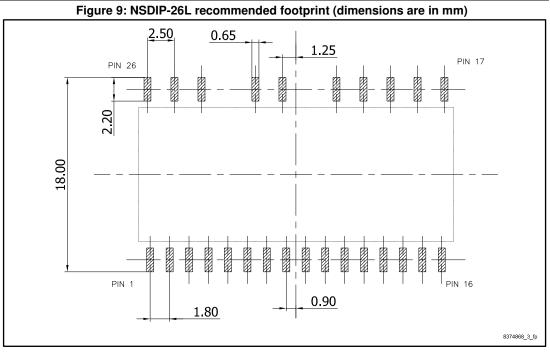
STIPNS2M50-H

nformation			STIPNS2M50-H			
Table 16: NSDIP-26L package mechanical data						
Dim.		mm				
Dini.	Min.	Тур.	Max.			
A			3.45			
A1	0.10		0.25			
A2	3.00	3.10	3.20			
A3	1.70	1.80	1.90			
b	0.47		0.57			
b1	0.45	0.50	0.55			
b2	0.63		0.67			
С	0.47		0.57			
c1	0.45	0.50	0.55			
D	29.05	29.15	29.25			
D1	0.70					
D2	0.45					
D3	0.90					
D4			29.65			
E	12.35	12.45	12.55			
E1	16.70	17.00	17.30			
E2	0.35					
е	1.70	1.80	1.90			
e1	2.40	2.50	2.60			
L	1.24	1.39	1.54			
L1	1.00	1.15	1.30			
L2		0.25 BSC				
L3		2.275 REF				
R1	0.25	0.40	0.55			
R2	0.25	0.40	0.55			
S		0.39	0.55			
θ	0°		8°			
θ1		3° BSC				
θ2	10°	12°	14°			



#### STIPNS2M50-H

Package information





#### **Revision history** 7

Date	Revision	Changes
12-Apr-2017	1	Initial release.
17-Jan-2018	2	<ul> <li>Datasheet promoted from preliminary data to production data.</li> <li>Modified features on cover page.</li> <li>Modified Table 3: "Inverter part", Table 5: "Total system", Table 6: "Thermal data", Table 13: "Sense comparator characteristics".</li> <li>Updated Section 6: "Package information".</li> <li>Minor text changes.</li> </ul>



#### STIPNS2M50-H

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